

AON6426

30V N-Channel MOSFET

General Description

The AON6426 combines advanced trench MOSFET technology with a low resistance package to provide extremely low $R_{\text{DS(ON)}}$. This device is ideal for load switch and battery protection applications.

Product Summary

 $V_{DS}(V) = 30V$

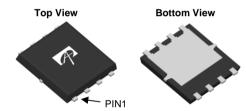
 $I_D = 65A$ $(V_{GS} = 10V)$

$$\begin{split} R_{DS(ON)} < 5.5 m\Omega & (V_{GS} = 10 V) \\ R_{DS(ON)} < 7.5 m\Omega & (V_{GS} = 4.5 V) \end{split}$$

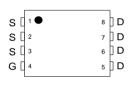
100% UIS Tested! 100% R_g Tested!

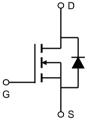


DFN5X6









Absolute Maximum Ratings T_A=25°C unless otherwise noted

Parameter		Symbol	Maximum	Units	
Drain-Source Voltage		V _{DS}	30	V	
Gate-Source Voltage		V_{GS}	±20	V	
Continuous Drain Current	T _C =25°C		65		
	T _C =100°C	I _D	43	A	
Pulsed Drain Current ^C		I _{DM}	130	7	
Continuous Drain Current	T _A =25°C		14	Δ	
	T _A =70°C	I _{DSM}	11	A	
Avalanche Current ^C		I _{AR}	42	A	
Repetitive avalanche energy L=0.1mH ^C		E _{AR}	88	mJ	
Power Dissipation ^B	T _C =25°C	В	42	W	
	T _C =100°C	$-P_{D}$	17	T vv	
	T _A =25°C	В	2	10/	
Power Dissipation ^A	T _A =70°C	P _{DSM}	1.2	W	
Junction and Storage Temperature Range		T _J , T _{STG}	-55 to 150	°C	

Thermal Characteristics								
Parameter	Symbol	Тур	Max	Units				
Maximum Junction-to-Ambient A	t ≤ 10s	D	24	30	°C/W			
Maximum Junction-to-Ambient AD	Steady-State $R_{\theta JA}$		53	64	°C/W			
Maximum Junction-to-Case Steady-S		$R_{\theta JC}$	2.6	3	°C/W			



Electrical Characteristics (T_J=25°C unless otherwise noted)

Symbol	Parameter	Conditions		Тур	Max	Units				
STATIC PARAMETERS										
BV _{DSS}	Drain-Source Breakdown Voltage	$I_D = 250 \mu A, V_{GS} = 0 V$	30	36.7		V				
I _{DSS}	Zero Gate Voltage Drain Current	V _{DS} =30V, V _{GS} =0V			1	μА				
		T _J =55°C			5					
I_{GSS}	Gate-Body leakage current	V_{DS} =0V, V_{GS} = ±20V			100	nA				
$V_{GS(th)}$	Gate Threshold Voltage	$V_{DS}=V_{GS} I_{D}=250\mu A$	1.3	1.8	2.5	V				
$I_{D(ON)}$	On state drain current	V_{GS} =10V, V_{DS} =5V	130			Α				
	Static Drain-Source On-Resistance	V _{GS} =10V, I _D =20A		4.5	5.5	mΩ				
R _{DS(ON)}		T _J =125°C		6.8	8.2	11122				
		V_{GS} =4.5V, I_D =20A		6	7.5	mΩ				
g _{FS}	Forward Transconductance	$V_{DS}=5V$, $I_{D}=20A$		53		S				
V_{SD}	Diode Forward Voltage	$I_S=1A, V_{GS}=0V$		0.7	1	V				
I _S	Maximum Body-Diode Continuous Current				40	Α				
DYNAMIC	PARAMETERS									
C _{iss}	Input Capacitance			1930	2300	pF				
C _{oss}	Output Capacitance	V_{GS} =0V, V_{DS} =15V, f=1MHz		290		pF				
C_{rss}	Reverse Transfer Capacitance]		230		pF				
R_g	Gate resistance	V_{GS} =0V, V_{DS} =0V, f=1MHz	0.7	1.4	2.1	Ω				
SWITCHII	NG PARAMETERS									
Q _g (10V)	Total Gate Charge			37	45	nC				
Q _g (4.5V)	Total Gate Charge	V _{GS} =10V, V _{DS} =15V, I _D =20A		18		nC				
Q_{gs}	Gate Source Charge	V _{GS} =10V, V _{DS} =13V, I _D =20A		4.8		nC				
Q_{gd}	Gate Drain Charge]		11		nC				
t _{D(on)}	Turn-On DelayTime			8.1		ns				
t _r	Turn-On Rise Time	V_{GS} =10V, V_{DS} =15V, R_{L} =0.75 Ω ,		8.6		ns				
t _{D(off)}	Turn-Off DelayTime	$R_{GEN}=3\Omega$		29		ns				
t _f	Turn-Off Fall Time	<u>]</u> _		8		ns				
t _{rr}	Body Diode Reverse Recovery Time	I _F =20A, dI/dt=500A/μs		14	17	ns				
Q _{rr}	Body Diode Reverse Recovery Charge	I _F =20A, dI/dt=500A/μs		40		nC				

A: The value of $R_{\theta,JA}$ is measured with the device mounted on 1in^2 FR-4 board with 2oz. Copper, in a still air environment with T_A =25°C. The Power dissipation P_{DSM} is based on $R_{\theta,JA}$ and the maximum allowed junction temperature of 150°C. The value in any given application depends on the user's specific board design.

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B. The power dissipation P_D is based on $T_{J(MAX)}$ =150°C, using junction-to-case thermal resistance, and is more useful in setting the upper dissipation limit for cases where additional heatsinking is used.

C. Repetitive rating, pulse width limited by junction temperature T_{J(MAX)}=150°C. Ratings are based on low frequency and duty cycles to keep initial T. =25°C.

D. The $R_{\theta,IA}$ is the sum of the thermal impedence from junction to case $R_{\theta,IC}$ and case to ambient.

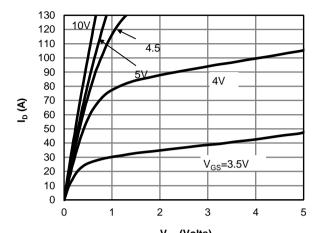
E. The static characteristics in Figures 1 to 6 are obtained using <300μs pulses, duty cycle 0.5% max.

F. These curves are based on the junction-to-case thermal impedence which is measured with the device mounted to a large heatsink, assuming a maximum junction temperature of T_{J(MAX)}=150°C. The SOA curve provides a single pulse rating.

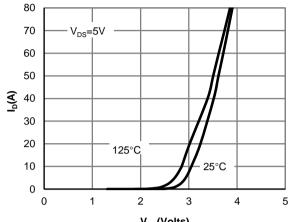
G. These tests are performed with the device mounted on 1 in² FR-4 board with 2oz. Copper, in a still air environment with T_A=25°C.



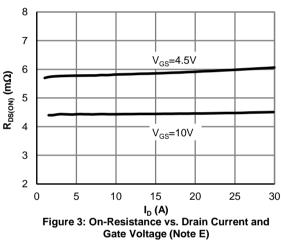
TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS



 V_{DS} (Volts) Fig 1: On-Region Characteristics (Note E)



V_{GS}(Volts) Figure 2: Transfer Characteristics (Note E)



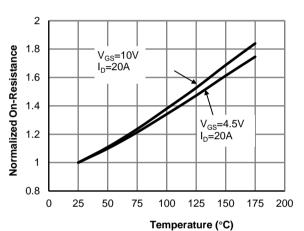
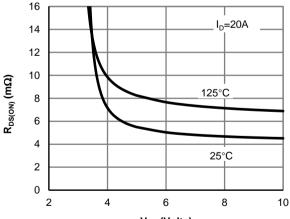
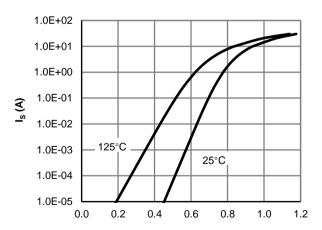


Figure 4: On-Resistance vs. Junction Temperature (Note E)



V_{GS} (Volts) Figure 5: On-Resistance vs. Gate-Source Voltage (Note E)



V_{SD} (Volts)
Figure 6: Body-Diode Characteristics (Note E)



TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

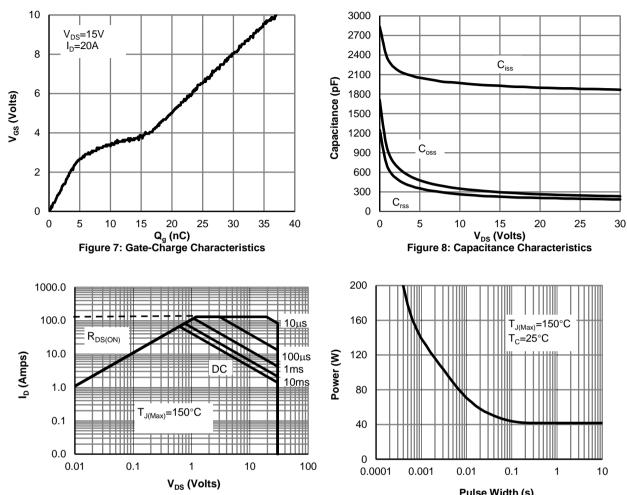


Figure 9: Maximum Forward Biased Safe Operating Area (Note F)

Pulse Width (s)
Figure 10: Single Pulse Power Rating Junction-toCase (Note F)

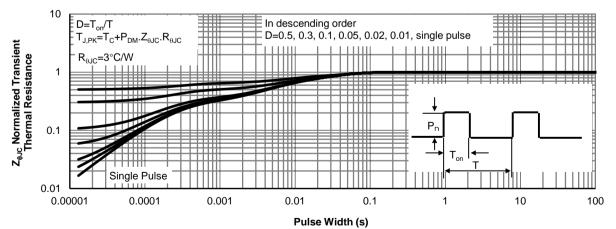
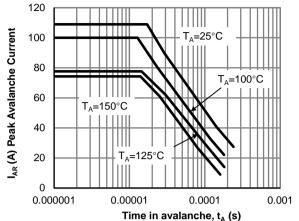


Figure 11: Normalized Maximum Transient Thermal Impedance (Note F)



TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS



Time in avalanche, t_A (s)
Figure 12: Single Pulse Avalanche capability (Note

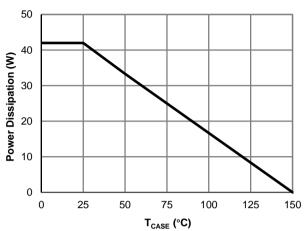


Figure 13: Power De-rating (Note F)

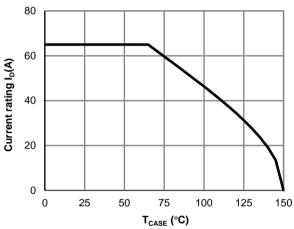
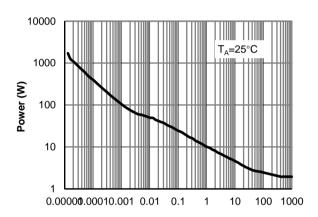
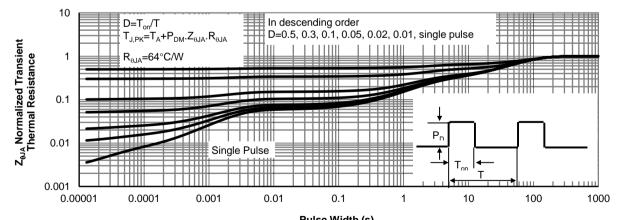


Figure 14: Current De-rating (Note F)



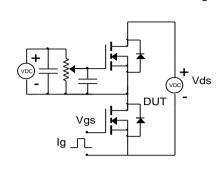
Pulse Width (s)
Figure 15: Single Pulse Power Rating Junction-toAmbient (Note G)

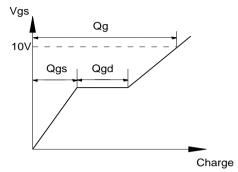


Pulse Width (s)
Figure 16: Normalized Maximum Transient Thermal Impedance (Note G)

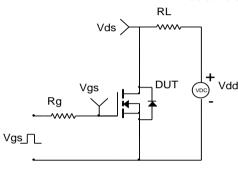


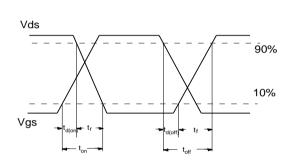
Gate Charge Test Circuit & Waveform



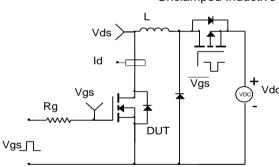


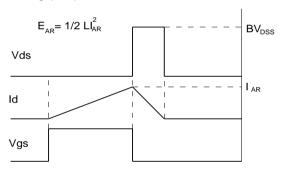
Resistive Switching Test Circuit & Waveforms





Unclamped Inductive Switching (UIS) Test Circuit & Waveforms





Diode Recovery Test Circuit & Waveforms

